



**AO3422**

**N-Channel Enhancement Mode Field Effect Transistor**

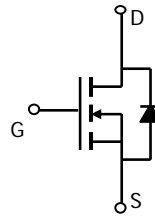
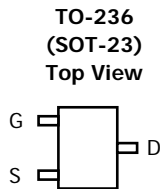


**General Description**

The AO3422 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. It offers operation over a wide gate drive range from 2.5V to 12V. This device is suitable for use as a load switch. Standard product AO3422 is Pb-free (meets ROHS & Sony 259 specifications). AO3422L is a Green Product ordering option. AO3422 and AO3422L are electrically identical.

**Features**

- $V_{DS}$  (V) = 55V
- $I_D$  = 2.1A ( $V_{GS}$  = 4.5V)
- $R_{DS(ON)}$  < 160m $\Omega$  ( $V_{GS}$  = 4.5V)
- $R_{DS(ON)}$  < 200m $\Omega$  ( $V_{GS}$  = 2.5V)



**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                              | Symbol         | Maximum                | Units            |
|--|----------------|------------------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$       | 55                     | V                |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 12$               | V                |
| Continuous Drain Current <sup>A</sup>  | $I_D$          | $T_A=25^\circ\text{C}$ | A                |
|  |                | $T_A=70^\circ\text{C}$ |                  |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$       | 10                     |                  |
| Power Dissipation                      | $P_D$          | $T_A=25^\circ\text{C}$ | W                |
|  |                | $T_A=70^\circ\text{C}$ |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150             | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 75           | 100 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | Steady-State | 115 | 150                |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 48           | 60  | $^\circ\text{C/W}$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min                      | Typ                                    | Max        | Units         |
|-----------------------------|---------------------------------------|---|--------------------------|--|------------|---------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |                          |  |            |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=10\text{mA}$ , $V_{GS}=0\text{V}$  | 55                       |  |            | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=44\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                  |                          |  | 1<br>5     | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-Source leakage current           | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 12\text{V}$  |                          |  | $\pm 100$  | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$  | 0.6                      | 1.3                                    | 2          | V             |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=4.5\text{V}$ , $V_{DS}=5\text{V}$   | 10                       |  |            | A             |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=4.5\text{V}$ , $I_D=2.1\text{A}$<br>$T_J=125^\circ\text{C}$                 |                          | 125<br>175                             | 160<br>210 | m $\Omega$    |
|                             |                                       | $V_{GS}=2.5\text{V}$ , $I_D=1.5\text{A}$  |                          | 157                                    | 200        |               |
|                             |                                       | $g_{FS}$  | Forward Transconductance | $V_{DS}=5\text{V}$ , $I_D=2.1\text{A}$ |            | 11            |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$   |                          | 0.78                                   | 1          | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |                          |  | 1          | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |                          |  |            |               |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=25\text{V}$ , $f=1\text{MHz}$                          |                          | 214                                    | 300        | pF            |
| $C_{oss}$                   | Output Capacitance                    |   |                          | 31                                     |            | pF            |
| $C_{rss}$                   | Reverse Transfer Capacitance          |   |                          | 12.6                                   |            | pF            |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                           |                          | 1.3                                    | 3          | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                       |   |                          |  |            |               |
| $Q_g$                       | Total Gate Charge                     | $V_{GS}=4.5\text{V}$ , $V_{DS}=27.5\text{V}$ , $I_D=2.1\text{A}$                    |                          | 2.6                                    | 3.3        | nC            |
| $Q_{gs}$                    | Gate Source Charge                    |   |                          | 0.6                                    |            | nC            |
| $Q_{gd}$                    | Gate Drain Charge                     |   |                          | 0.8                                    |            | nC            |
| $t_{D(on)}$                 | Turn-On Delay Time                    | $V_{GS}=10\text{V}$ , $V_{DS}=27.5\text{V}$ , $R_L=12\Omega$ ,<br>$R_{GEN}=3\Omega$ |                          | 2.3                                    |            | ns            |
| $t_r$                       | Turn-On Rise Time                     |   |                          | 2.4                                    |            | ns            |
| $t_{D(off)}$                | Turn-Off Delay Time                   |   |                          | 16.5                                   |            | ns            |
| $t_f$                       | Turn-Off Fall Time                    |   |                          | 2                                      |            | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=2.1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |                          | 20                                     | 30         | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=2.1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |                          | 17                                     |            | nC            |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $\leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 $\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

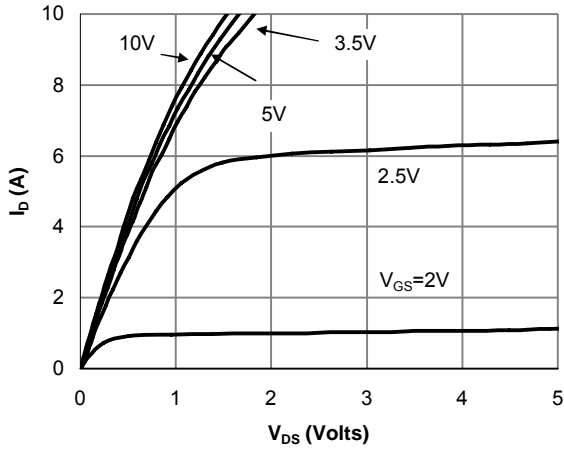


Fig 1: On-Region characteristics

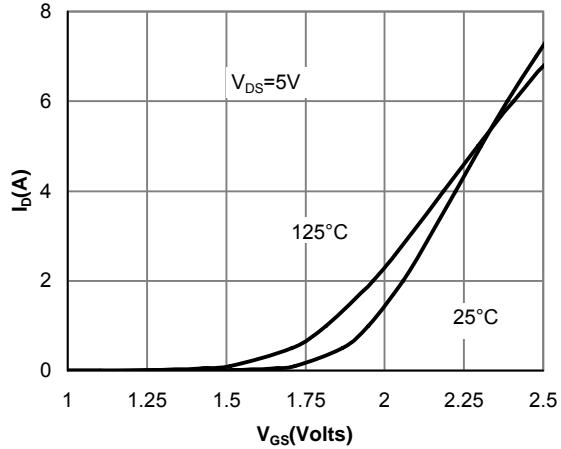


Figure 2: Transfer Characteristics

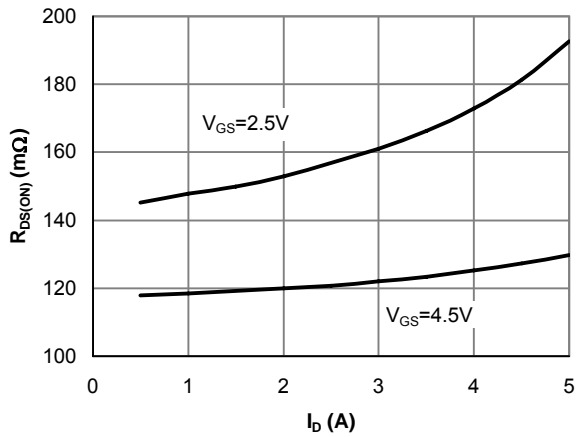


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

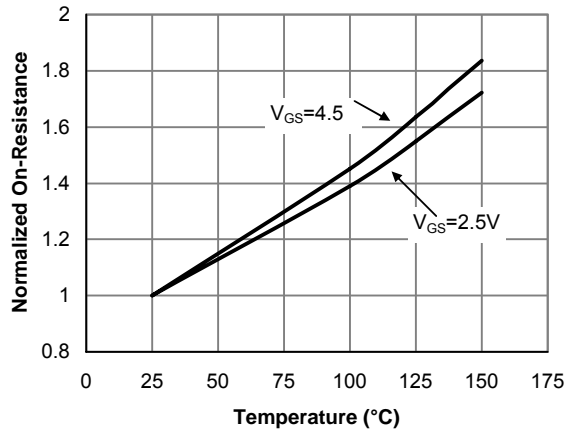


Figure 4: On-Resistance vs. Junction Temperature

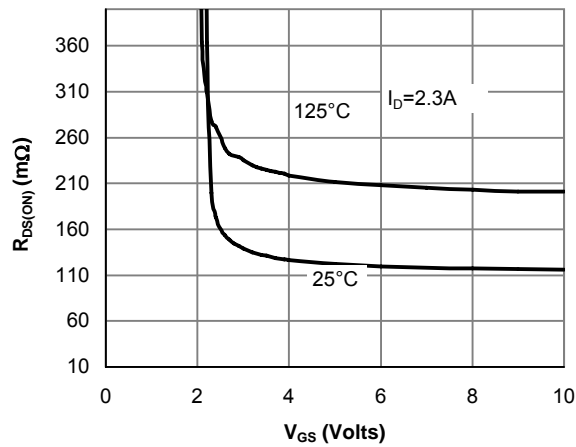


Figure 5: On-Resistance vs. Gate-Source Voltage

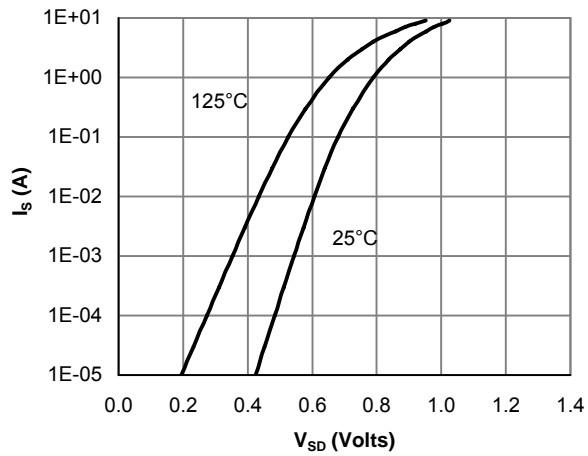


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

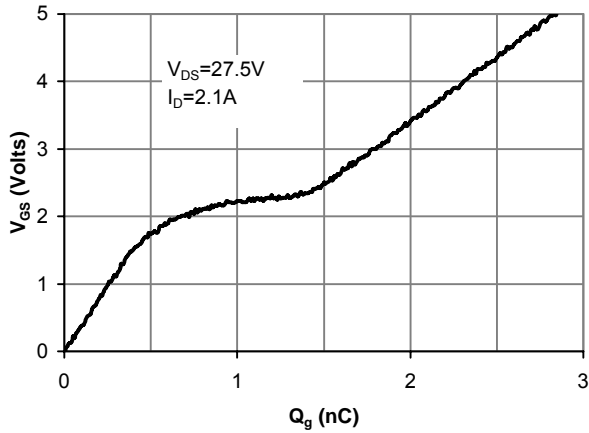


Figure 7: Gate-Charge Characteristics

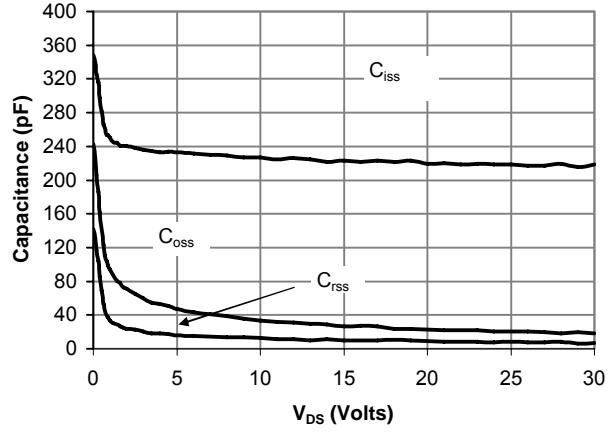


Figure 8: Capacitance Characteristics

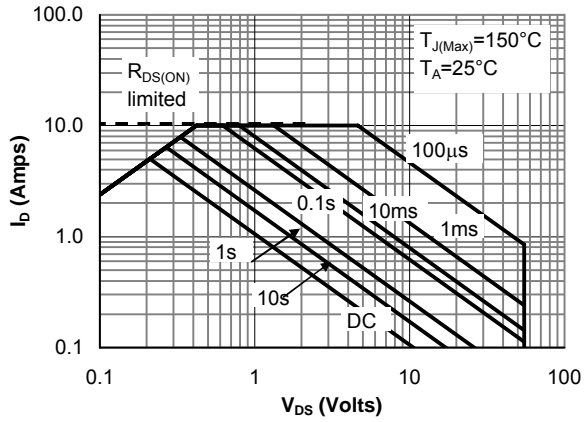


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

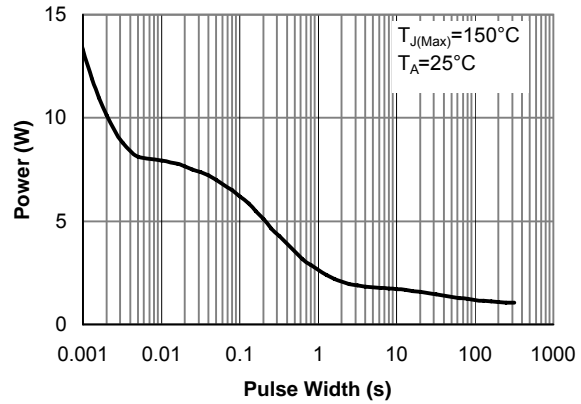


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

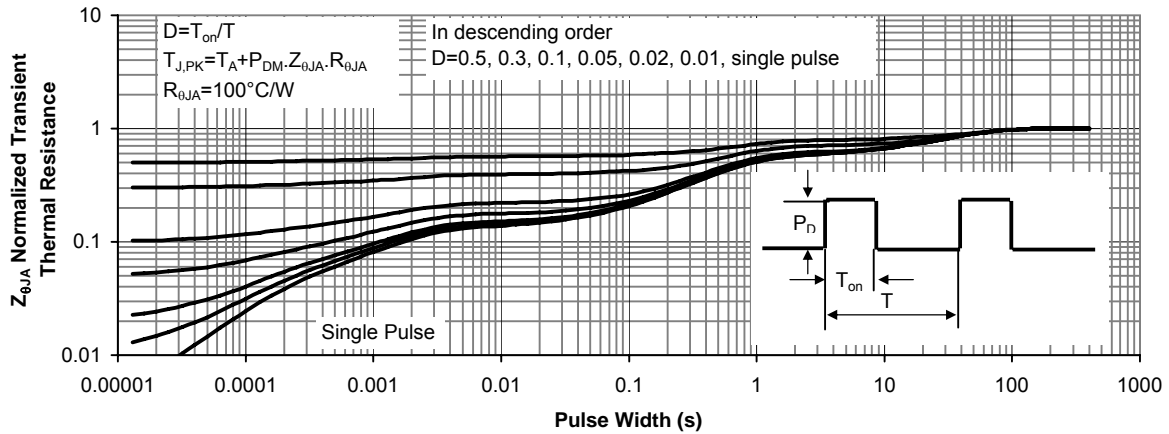


Figure 11: Normalized Maximum Transient Thermal Impedance